# ELEC-313 Lab 2: Diode Characterization

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## 1 Objective

The objective is to observe the basic operation of a diode. In addition, the Schockley equation (Eq 2) is used to find the diode's reverse saturation current  $(I_S)$  and thermal voltage  $(V_T)$  using values measured in the lab.

## 2 Equipment

Diode: 1N4002 Power supply: HP E3631A Resistors:  $330\,\Omega,\,470\,\Omega,\,680\,\Omega$  Multimeter: Fluke 8010A (x2)

Resistive decade box: HeathKit IN-3117

### 3 Schematics

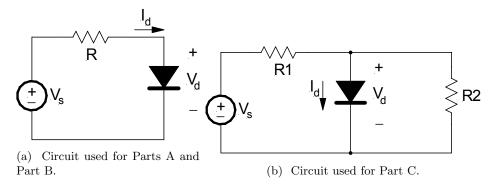


Figure 1: Circuits used in this lab.

#### 4 Procedure

#### 4.1 Part A

The circuit in Figure 1a was constructed with  $R=470\,\Omega$  and the power supply as  $V_s$ . The actual resistance was measured with one a multimeter and recorded in Table 1 along with the percent difference calculated (Eq 1). Next, the multimeters were used to measure voltage across and current through the diode ( $V_d$  and  $I_d$ , respectively) while  $V_s$  was swept from  $-5\,\mathrm{V}$  to  $10\,\mathrm{V}$ . The step size from  $-5\,\mathrm{V}$  to  $0\,\mathrm{V}$  and from  $5\,\mathrm{V}$  to  $10\,\mathrm{V}$  was  $0.5\,\mathrm{V}$ , and  $0.25\,\mathrm{V}$  from  $0\,\mathrm{V}$  to  $5\,\mathrm{V}$ . These values were recorded in Table 2 and plotted in Figure 2.

#### 4.2 Part B

The circuit in Figure 1a was constructed with the resistive decade box as R and the power supply as  $V_s$ . The multimeters were again used to measure diode

voltage  $(V_d)$  and current  $(I_d)$ . This time  $V_s$  was held at 10 V and R varied:  $200 \Omega$ ,  $500 \Omega$ ,  $1 k\Omega$ ,  $2 k\Omega$ ,  $5 k\Omega$ ,  $10 k\Omega$ ,  $20 k\Omega$ ,  $50 k\Omega$ ,  $100 k\Omega$ . These values were recorded in Table 3 and plotted in Figure 2.

#### 4.3 Part C

The circuit in Figure 1b was constructed with  $R_1 = 330 \,\Omega$ ,  $R_2 = 680 \,\Omega$ , and the power supply as  $V_s = 10 \,\mathrm{V}$ . The multimeters were again used to measure diode voltage  $(V_d)$  and current  $(I_d)$ . Finally, the diode was removed and a multimeter was used to measure the voltage at that node  $(V_{OC})$ . These values were recorded in Table 4.

## 5 Results

	Nominal	Measured	% Difference
	$(\Omega)$	$(\Omega)$	
$R_1$	470	465.3	1.00

Table 1: Comparison of nominal and measured resistance in Part A.

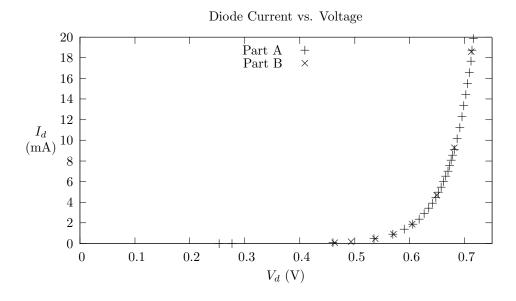


Figure 2: Diode characteristics measured in Parts A and B.

$V_s$ (V)	$V_d$ (V)	$I_d \; (\mathrm{mA})$		$V_s$ (V)	$V_d$ (V)	$I_d \text{ (mA)}$
-5.00	-5.000	0.01	-	. ,	. ,	
-4.50	-4.500	0.01		2.75	0.648	4.44
-4.00	-4.000	0.01		3.00	0.653	4.95
-3.50	-3.500	0.01		3.25	0.658	5.47
-3.00	-3.000	0.01		3.50	0.662	5.99
				3.75	0.666	6.51
-2.50	-2.500	0.01		4.00	0.670	7.03
-2.00	-2.000	0.01		4.25	0.673	7.55
-1.50	-1.500	0.01		4.50	0.676	8.08
-1.00	-1.000	0.01		4.75	0.679	8.60
-0.50	-0.500	0.01		5.00	0.682	9.13
0.00	0.277	0.010			0.687	
0.25	0.254	0.010		5.50		10.18
0.50	0.461	0.105		6.00	0.692	11.23
0.75	0.536	0.469		6.50	0.696	12.30
1.00	0.570	0.922		7.00	0.699	13.36
1.25	0.570 $0.591$	1.40		7.50	0.703	14.42
				8.00	0.706	15.49
1.50	0.606	1.89		8.50	0.709	16.56
1.75	0.618	2.39		9.00	0.712	17.66
2.00	0.627	2.90		9.50	0.714	18.75
2.25	0.635	3.41		10.00	0.717	19.84
2.50	0.642	3.92		10.00	0.111	13.04

Table 2: Diode characteristics measured in Part A.

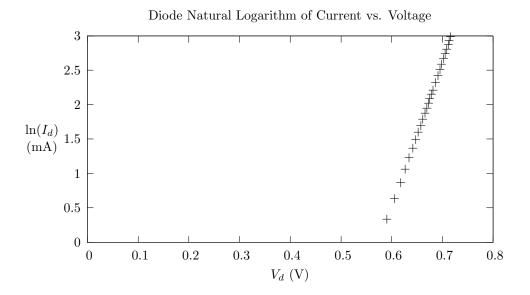


Figure 3:  $\ln(I_d)$  vs.  $V_d$ .

$R(\Omega)$	$V_d$ (V)	$I_d  (\mathrm{mA})$
200	0.751	46.00
500	0.713	18.60
1k	0.682	9.30
2k	0.650	4.70
5k	0.605	1.85
10k	0.571	0.94
20k	0.538	0.47
50k	0.494	0.19
100k	0.464	0.10

Table 3: Diode characteristics measured in Part B.

$$\frac{V_d \text{ (V)} \quad I_d \text{ (mA)} \quad V_{OC} \text{ (V)}}{0.712 \quad 27.2 \quad 6.70}$$

Table 4: Diode characteristics measured in Part C.

## 6 Conclusion

As seen in Figure 3, the graph of the natural log of  $I_d$  vs.  $V_d$  derived from Part A data (Table 2) generates a linear plot. The slope (m) of this line was then calculated using Equation 4, and used to determine the thermal voltage  $(V_T)$  (Eq 3). Two corresponding  $I_d$  and  $V_d$  values (shown in Table C) along with  $V_T$  were plugged into the Schockley equation (Eq 2) to derive the saturation current  $(I_S)$  seen in (Table C). The value of  $V_T$  is very close to the assumed value of 0.026 V. Also the value of  $I_S$  seems to be close to what is typically seen in circuits textbooks thus showing that diode parameters can be calculated by using the Schockley equation. As seen in Table A, the measured values of  $V_d$  and the  $I_d$  taken in Part B of the experiment were very close to the theoretical values calculated in PSpice. The largest %difference was only 2.65%. As seen in Table B, the measured values of  $V_d$  and the  $I_d$  taken in Part C of the experiment were very close to the theoretical values calculated in PSpice. The largest %difference was on 4.17%.

## 7 Equations

$$\%_{diff} = \frac{|nominal - measured|}{nominal} 100\%$$
 (1)

Table 5: Results from data analysis.

$$I_D = I_S \left( e^{\frac{V_D}{V_T}} - 1 \right) \tag{2}$$

$$m = \frac{1}{V_T} \tag{3}$$

$$m = \frac{\ln(I_2) - \ln(I_1)}{V_2 - V_1} \tag{4}$$